

BlueNRG

Bluetooth® low energy wireless network processor

Datasheet - production data



Features

- Bluetooth specification v4.0 compliant master and slave single-mode Bluetooth low energy network processor
- Embedded Bluetooth low energy protocol stack: GAP, GATT, SM, L2CAP, LL, RF-PHY
- Bluetooth low energy profiles provided separately
- Operating supply voltage: from 2.0 to 3.6 V
- 8.2 mA maximum TX current (@0 dBm, 3.0 V)
- Down to 1.7 µA current consumption with active BLE stack
- Integrated linear regulator and DC-DC stepdown converter
- Up to +8 dBm available output power (at antenna connector)
- Excellent RF link budget (up to 96 dB)
- Accurate RSSI to allow power control
- Proprietary application controller interface (ACI), SPI based, allows interfacing with an external host application microcontroller
- Full link controller and host security
- High performance, ultra-low power Cortex-M0 32-bit based architecture core

- On-chip non-volatile Flash memory
- AES security co-processor
- Low power modes
- 16 or 32 MHz crystal oscillator
- 12 MHz ring oscillator
- 32 kHz crystal oscillator
- 32 kHz ring oscillator
- Compliant with the following radio frequency regulations: ETSI EN 300 328, EN 300 440, FCC CFR47 Part 15, ARIB STD-T66
- Available in QFN32 (5 x 5 mm) and WLCSP34 (2.66 x 2.56 mm) packages
- Operating temperature range: -40 °C to 85 °C

Applications

- Watches
- Fitness, wellness and sports
- Consumer medical
- Security/proximity
- Remote control
- Home and industrial automation
- Assisted living
- Mobile phone peripherals
- PC peripherals

Table 1: Device summary

Order code	Package	Packing			
BLUENRGQTR	QFN32 (5 x 5 mm)	Tape and reel			
BLUENRGCSP	WLCSP34 (2.66 x 2.56 mm)	Tape and reel			

May 2015

1/44

This is information on a product in full production.

Contents

CUI	nems		
1	Descrip	tion	5
2	General	description	6
3	Pin dese	cription	8
4	Applicat	tion circuits	11
5	Block di	agram and descriptions	
	5.1	Core, memory and peripherals	
	5.2	Power management	
	5.3	Clock management	17
	5.4	Bluetooth low energy radio	17
6	Operatir	ng modes	19
7	Applicat	tion controller interface	
8	Absolut	e maximum ratings and thermal data	23
9	General	characteristics	24
10	Electrica	al specification	
	10.1	Electrical characteristics	
	10.2	RF general characteristics	
	10.3	RF transmitter characteristics	
	10.4	RF receiver characteristics	
	10.5	High speed crystal oscillator (HSXOSC) characteristics	
		10.5.1 High speed crystal oscillator (HSXOSC)	
	10.6	Low speed crystal oscillator (LSXOSC) characteristics	
	10.7	High speed ring oscillator (HSROSC) characteristics	
	10.8	Low speed ring oscillator (LSROSC) characteristics	
	10.9	N-fractional frequency synthesizer characteristics	
11	•	e information	
	11.1	QFN32 package information	
	11.2	WLCSP34 package information	
12		sembly guidelines	
13	Revisio	n history	



List of tables

Table 1: Device summary	1
Table 2: Pinout description	
Table 3: External component list	13
Table 4: SPI interface	
Table 5: BlueNRG operating modes	20
Table 6: BlueNRG transition times	21
Table 7: Absolute maximum ratings	
Table 8: Thermal data	
Table 9: Recommended operating conditions	
Table 10: Electrical characteristics	
Table 11: RF general characteristics	
Table 12: RF Transmitter characteristics	
Table 13: RF receiver characteristics	29
Table 14: High speed crystal oscillator characteristics	
Table 15: Low speed crystal oscillator characteristics	
Table 16: High speed ring oscillator characteristics	
Table 17: Low speed ring oscillator characteristics	
Table 18: N-fractional frequency synthesizer characteristics	
Table 19: QFN32 (5 x 5 x 1 pitch 0.5 mm) mechanical data	
Table 20: WLCSP34 (2.66 x 2.56 x 0.5 pitch 0.4 mm) mechanical data	39
Table 21: Flip Chip CSP (2.66 x 2.56 x 0.5 pitch 0.4 mm) package reflow profile recommendation	40
Table 22: Document revision history	42



List of figures

Figure 1: BlueNRG application block diagram	7
Figure 2: BlueNRG pinout top view (QFN32)	8
Figure 3: BlueNRG pinout top view (WLCSP34)	
Figure 4: BlueNRG pinout bottom view (WLCSP34)	
Figure 5: BlueNRG application circuit: active DC-DC converter QFN32 package	
Figure 6: BlueNRG application circuit: non active DC-DC converter QFN32 package	12
Figure 7: BlueNRG application circuit: active DC-DC converter WLCSP package	12
Figure 8: BlueNRG application circuit: non active DC-DC converter WLCSP package	13
Figure 9: BlueNRG block diagram	
Figure 10: Power management strategy using LDO	
Figure 11: Power management strategy using step-down DC-DC converter	
Figure 12: Simplified state machine	20
Figure 13: Simplified block diagram of the amplitude regulated oscillator	32
Figure 14: QFN32 (5 x 5 x 1 pitch 0.5 mm) package outline	36
Figure 15: QFN32 (5 x 5 x 1 pitch 0.5 mm) package detail "A"	37
Figure 16: WLCSP34 (2.66 x 2.56 x 0.5 pitch 0.4 mm) package outline	38
Figure 17: Flip Chip CSP (2.66 x 2.56 x 0.5 pitch 0.4 mm) package reflow profile recommendation	



1 Description

The BlueNRG is a very low power Bluetooth low energy (BLE) single-mode network processor, compliant with Bluetooth specification v4.0. The BlueNRG can act as master or slave. The entire Bluetooth low energy stack runs on the embedded Cortex M0 core. The non-volatile Flash memory allows on-field stack upgrading. The BlueNRG allows applications to meet the tight advisable peak current requirements imposed by the use of standard coin cell batteries. The maximum peak current is only 10 mA at 1 dBm of output power. Ultra low-power sleep modes and very short transition times between operating modes allow very low average current consumption, resulting in longer battery life. The BlueNRG offers the option of interfacing with external microcontrollers using SPI transport layer.



2 General description

The BlueNRG is a single-mode Bluetooth low energy master/slave network processor, compliant with the Bluetooth specification v4.0.

It integrates a 2.4 GHz RF transceiver and a powerful Cortex-M0 microcontroller, on which a complete power-optimized stack for Bluetooth single mode protocol runs, providing:

- full master and slave role support
- GAP: central, peripheral, observer or broadcaster roles
- ATT/GATT: client and server
- SM: privacy, authentication and authorization
- L2CAP
- Link Layer: AES-128 encryption and decryption

An on-chip non-volatile Flash memory allows on-field Bluetooth low energy stack upgrade.

The device allows applications to meet the tight advisable peak current requirements imposed by the use of standard coin cell batteries. If the high efficiency embedded DC-DC step-down converter is used, the maximum input current is only 15 mA at the highest output power (+8 dBm). Even if the DC-DC converter is not used, the maximum input current is only 29 mA at the highest output power, still preserving battery life.

Ultra low-power sleep modes and very short transition time between operating modes result in very low average current consumption during real operating conditions, providing very long battery life.

Two different external matching networks are suggested: standard mode (TX output power up to +5 dBm) and high power mode (TX output power up to +8 dBm).

The external host application processor, where the application resides, is interfaced with the BlueNRG through an application controller interface protocol based on a standard SPI interface.





57

3 Pin description

The BlueNRG pinout is shown in *Figure 2: "BlueNRG pinout top view (QFN32)", Figure 3: "BlueNRG pinout top view (WLCSP34)"* and *Figure 4: "BlueNRG pinout bottom view (WLCSP34)"*. In *Table 2: "Pinout description"* a short description of the pins is provided.







57



Note: Top view (balls are underneath).



	Table 2: Pinout description						
Pin	S	Name	I/O	Description			
QFN32	WLCSP	Name	1/0	Description			
1	E2	SPI_MOSI	Ι	SPI_MOSI			
2	E1	SPI_CLK	I	SPI_CLK			
3	D2	SPI_IRQ	O SPI_IRQ				
4	D1	TEST1	I/O	Test pin			
5	C1	VBAT3	VDD	2.0-3.6 battery voltage input			
6	C2	TEST2	I/O	Test pin connected to GND			
7	B1	TEST3	I/O	Test pin connected to GND			
8	B2	TEST4	I/O	Test pin connected to GND			
9	A1	TEST5	I/O	Test pin connected to GND			
10	B3	TEST6	I/O	Test pin connected to GND			
11	A2	TEST7	I/O	Test pin connected to GND			
12	A3	VDD1V8	0	1.8 V digital core			
13	A4	TEST8	I/O	Test pin not connected			
14	A5	TEST9	I/O	Test pin not connected			
15	B4	TEST11	I/O	Test pin not connected (QFN32) Test pin connected to GND (WLCSP)			
16	B5	TEST12	I/O	Test pin not connected (QFN32) Test pin connected to GND (WLCSP)			
17	A6	FXTAL1	I	16/32 MHz crystal			
18	B6	FXTAL0	I	16/32 MHz crystal			
19	-	VBAT2	VDD	2.0-3.6 battery voltage input			
20	C6	RF1	I/O	Antenna + matching circuit			
21	D6	RF0	I/O	Antenna + matching circuit			
22	E6	SXTAL1	I	32 kHz crystal			
23	E5	SXTAL0	I	32 kHz crystal			
24	D5	VBAT1	VDD	2.0-3.6 battery voltage input			
25	E4	RESETN	I	Reset			
26	F6	SMPSFILT1	0	SMPS output			
27	-	NO_SMPS	I	Power management strategy selection			
28	F5	SMPSFILT2	I/O	SMPS input/output			
29	F3	VDD1V2	0	1.2 V digital core			
30	E3	TEST10	I/O	TEST pin connected to GND			
31	F2	SPI_CS	I	SPI_CS			
32	F1	SPI_MISO	0	SPI_MISO			
-	C3	GND	GND	Ground			
-	D3	GND	GND	Ground			
-	D4	GND	GND	Ground			
-	F4	SMPS-GND	GND	SMPS ground			



4 Application circuits

The schematics below are purely indicative. For more detailed schematics, please refer to the "Reference design" and "Layout guidelines" which are provided as separate documents.



Figure 5: BlueNRG application circuit: active DC-DC converter QFN32 package



Figure 6: BlueNRG application circuit: non active DC-DC converter QFN32 package



Figure 7: BlueNRG application circuit: active DC-DC converter WLCSP package







Table 3: External component list

Component	Description
C1	Decoupling capacitor
C2	DC-DC converter output capacitor
C3	DC-DC converter output capacitor
C4	Decoupling capacitor for 1.2 V digital regulator
C5	Decoupling capacitor for 1.2 V digital regulator
C6	Decoupling capacitor
C7	32 kHz crystal loading capacitor ⁽¹⁾
C8	32 kHz crystal loading capacitor ⁽¹⁾
C9	RF balun/matching network capacitor High Performance
	RF balun/matching network capacitor Standard mode
C10	RF balun/matching network capacitor High Performance
	RF balun/matching network capacitor Standard mode
C11	RF balun/matching network capacitor High Performance
	RF balun/matching network capacitor Standard mode
C12	Decoupling capacitor
C13	Decoupling capacitor
C14	RF balun/matching network capacitor High Performance
014	RF balun/matching network capacitor Standard mode
C15	RF balun/matching network capacitor High Performance
015	RF balun/matching network capacitor Standard mode



Application circuits

Component	Description
C16	RF balun/matching network capacitor High Performance
	RF balun/matching network capacitor Standard mode
C17	16/32 MHz crystal loading capacitor
C18	16/32 MHz crystal loading capacitor
C19	Decoupling capacitor for 1.8 V digital regulator
C20	Decoupling capacitor for 1.8 V digital regulator
C21	RF balun/matching network capacitor High Performance, RF balun/matching network capacitor Standard mode
L1	DC-DC converter input inductor, Isat > 100 mA, Q > 25
12	RF balun/matching network inductor High Performance
L2	RF balun/matching network inductor Standard mode
L3	RF balun/matching network inductor High Performance
LJ	RF balun/matching network inductor Standard mode
14	RF balun/matching network inductor High Performance
L4	RF balun/matching network inductor Standard mode
R1	Pull-down resistor on the SPI_IRQ line
R I	(can be replaced by the internal pull-down of the Application MCU)
XTAL1	32 kHz crystal (optional)
XTAL2	16/32 MHz crystal

Notes:

⁽¹⁾Values valid only for the crystal NDK NX3215SA-32.768 kHz-EXS00A-MU00003. For other crystals refer to what specified in their datasheet.



5 Block diagram and descriptions

A block diagram of the BlueNRG is shown in *Figure 9: "BlueNRG block diagram"*. In the following subsections a short description of each module is given.



Figure 9: BlueNRG block diagram

5.1 Core, memory and peripherals

The BlueNRG contains an ARM Cortex-M0 microcontroller core that supports ultra-low leakage state retention mode and almost instantaneously returning to fully active mode on critical events.

The memory subsystem consists of 64 KB Flash, and 12 KB RAM , divided in two blocks of 6 KB (RAM1 and RAM2). Flash is used for the M0 program. No RAM or FLASH resources are available to the external microcontroller driving the BlueNRG.

The application controller interface (ACI) uses a standard SPI slave interface as transport layer, basing in five physical wires:

- 2 control wires (clock and slave select)
- 2 data wires with serial shift-out (MOSI and MISO) in full duplex
- 1 wire to indicate data availability from the slave

Table 4: SPI interface

Name	Direction	Width	Description
SPI_CS	In	1	SPI slave select = SPI enable.
SPI_CLK	In	1	SPI clock (max 8 MHz).
SPI_MOSI	In	1	Master output, slave input.



Block diagram and descriptions

BlueNRG

Name	Direction	Width	Description
SPI_MISO	Out	1	Master input, slave output.
SPI_IRQ	Out	1	Slave has data for master.

All the SPI pins have an internal pull-down except for the CSN that has a pull-up. All the SPI pins, except the CSN, are in high impedance state during the low-power states. The IRQ pin needs a pull-down external resistor.

5.2 **Power management**

The BlueNRG integrates both a low dropout voltage regulator (LDO) and a step-down DC-DC converter, and one of them can be used to power the internal BlueNRG circuitry. However even when the LDO is used, the stringent maximum current requirements, which are advisable when coin cell batteries are used, can be met and further improvements can be obtained with the DC-DC converter at the sole additional cost of an inductor and a capacitor.

The internal LDOs supplying both the 1.8 V digital blocks and 1.2 V digital blocks require decoupling capacitors for stable operation.

Figure 10: "Power management strategy using LDO" and *Figure 11: "Power management strategy using step-down DC-DC converter"*, show the simplified power management schemes using LDO and DC-DC converter.



Figure 10: Power management strategy using LDO



Figure 11: Power management strategy using step-down DC-DC converter



5.3 Clock management

The BlueNRG integrates two low-speed frequency oscillators (LSOSC) and two High speed (16 MHz or 32 MHz) frequency oscillators (HSOSC).

The low frequency clock is used in Low Power mode and can be supplied either by a 32.7 kHz oscillator that uses an external crystal and guarantee up to ± 50 ppm frequency tolerance, or by a ring oscillator with maximum ± 500 ppm frequency tolerance, which does not require any external components.

The primary high frequency clock is a 16 MHz or 32 MHz crystal oscillator. There is also a fast-starting 12 MHz ring oscillator that provides the clock while the crystal oscillator is starting up. Frequency tolerance of high speed crystal oscillator is \pm 50 ppm.

The usage of the 16 MHz (or 32 MHz) crystal is strictly necessary.

5.4 Bluetooth low energy radio

The BlueNRG integrates an RF transceiver compliant with the Bluetooth specification and the standard national regulations in the unlicensed 2.4 GHz ISM band.

The RF transceiver requires very few external discrete components. It provides 96 dB link budgets with excellent link reliability, keeping the maximum peak current below 15 mA.



In Transmit mode, the power amplifier (PA) drives the signal generated by the frequency synthesizer out to the antenna terminal through a very simple external network. The power delivered as well as the harmonic content depends on the external impedance seen by the PA.

The output power is programmable from -18 dBm to +8 dBm, to allow a user-defined power control system and to guarantee optimum power consumption for each scenario.



6 Operating modes

Several operating modes are defined for the BlueNRG:

- Reset mode
- Sleep mode
- Standby mode
- Active mode
- Radio mode
 - Receive Radio mode
 - Transmit Radio mode

In Reset mode, the BlueNRG is in ultra-low power consumption: all voltage regulators, clocks and the RF interface are not powered. The BlueNRG enters Reset mode by asserting the external reset signal. As soon as it is de-asserted, the device follows the normal activation sequence to transit to Active mode.

In Sleep mode either the low speed crystal oscillator or the low speed ring oscillator are running, whereas the high speed oscillators are powered down as well as the RF interface. The state of the BlueNRG is retained and the content of the RAM is preserved. Depending on the application, part of the RAM (RAM2 block) can be switched off during sleep to save more power (refer to stack mode 1, described in UM1868).

While in Sleep mode, the BlueNRG waits until an internal timer expires and then it goes into Active mode. The transition from Sleep mode to Active mode can also be activated through the SPI interface.

Standby mode and Sleep mode are equivalent but the low speed frequency oscillators are powered down. In Standby mode the BlueNRG can be activated through the SPI interface.

In Active mode the BlueNRG is fully operational: all interfaces, including SPI and RF, are active as well as all internal power supplies together with the high speed frequency oscillator. The MCU core is also running.

Radio mode differs from Active mode as also the RF transceiver is active and it is capable of either transmitting or receiving.

Figure 12: "Simplified state machine" reports the simplified state machine:







Table 5: BlueNRG operating modes

State	Digital LDO	SPI	LSOSC	HSOSC	Core	RF synt.	RX chain	TX chain
	OFF							
Reset	Register contents lost	OFF	OFF	OFF	OFF	OFF	OFF	OFF
	ON							
Standby	Register contents retained	ON	OFF	OFF	OFF	OFF	OFF	OFF
	ON							
Sleep	Register contents retained	ON	ON	OFF	OFF	OFF	OFF	OFF
	ON							
Active	Register contents retained	ON	-	ON	ON	OFF	OFF	OFF
	ON							
RX	Register contents retained	ON	-	ON	ON	ON	ON	OFF
	ON							
тх	Register contents retained	ON	-	ON	ON	ON	OFF	ON



BlueNRG

Operating modes

	Table 6: BlueNR	G transition times
Transition Maximum time		Condition
	1.5 ms	32 kHz not available
Reset-active ⁽¹⁾	7 ms	32 kHz RO
	94 ms	32 kHz XO
	0.42 ms	32 kHz not available
Standby-active ⁽¹⁾	6.2 ms	32 kHz RO
	93 ms	32 kHz XO
Sleep-active ⁽¹⁾	0.42 ms	
Active-RX	125 µs	Channel change
ACIIVE-KA	61 µs	No channel change
	131 µs	Channel change
Active-TX	67 µs	No channel change
RX-TX or TX-RX	150 µs	

Notes:

 $^{(1)}\mbox{These}$ measurements are taken using NX3225SA-16.000 MHz-EXS00A-CS05997.



7 Application controller interface

The application controller interface is based on a standard SPI module with speeds up to 8 MHz. The application controller Interface defines a software protocol providing functions to access all the services offered by the layers of the embedded Bluetooth stack. The ACI commands are described in the document "BlueNRG ACI command interface".



8 Absolute maximum ratings and thermal data

Absolute maximum ratings are those values above which damage to the device may occur. Functional operation under these conditions is not implied. All voltages are referred to GND.

Pin	Parameter	Value	Uni t
5, 19, 24, 26, 28	DC-DC converter supply voltage input and output	-0.3 to +3.9	V
12, 29	DC voltage on linear voltage regulator	-0.3 to +3.9	V
1, 2, 3, 4, 6, 7, 8, 9, 10, 11, 25, 27, 30, 31, 32	DC voltage on digital input/output pins	-0.3 to +3.9	V
13, 14, 15,16	DC voltage on analog pins	-0.3 to +3.9	V
17, 18, 22, 23	DC voltage on XTAL pins	-0.3 to +1.4	V
20, 21 ⁽¹⁾	DC voltage on RF pins	-0.3 to +1.4	V
T _{STG}	Storage temperature range	-40 to +125	°C
V _{ESD} -HBM	Electrostatic discharge voltage	±2.0	kV

Table 7:	Absolute	maximum	ratings
1 4 6 1 6	/ 10001010	maximani	. a

Notes:

⁽¹⁾+8 dBm input power at antenna connector in Standard mode, +11 dBm in High Power mode, with given reference design.

Symbo I	Parameter	Value	Uni t
$R_{thj-amb}$	Thermal resistance junction-ambient	34 (QFN32) 50 (WLCSP36)	°C/ W
R _{thj-c}	Thermal resistance junction-case	2.5 (QFN32) 25 (WLCSP36)	°C/ W

Table 8: Thermal data



9 General characteristics

Table 9: Recommended operating conditions

Symbol	Parameter		Тур.	Max.	Unit
V _{BAT}	Operating Battery supply voltage	2.0		3.6	V
T _A	Operating Ambient temperature range	-40		+85	°C



10 Electrical specification

10.1 Electrical characteristics

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25$ °C, $V_{BAT} = 3.0$ V. All performance data are referred to a 50 W antenna connector, via reference design, QFN32 package version.

Symbol	Parameter	Table 10: Electrical Test col		Min.	Тур.	Max.	Unit
Power co	onsumption when DC	C-DC converter active)				
		Reset			5		nA
		Chara dhu i	RAM2 OFF		1.3		
		Standby	RAM2 ON		2		μA
			32 kHz XO ON (RAM2 OFF)		1.7		
		Sleep	32 kHz XO ON (RAM2 ON)		2.4		μA
		Sleep	32 kHz RO ON (RAM2 OFF)		2.8		μΑ
			32 kHz RO ON (RAM2 ON)		3.5		
		Active	CPU, Flash and RAM off		2		mA
			CPU, Flash and RAM on		3.3		mA
I _{BAT}	Supply current	RX	High Power mode		7.7		mA
·BAT			Standard mode		7.3		
			+5 dBm		11		
			0 dBm		8.2		
			-2 dBm		7.2		
		TX Standard	-6 dBm		6.7		mA
		mode	-9 dBm		6.3		
			-12 dBm		6.1		
			-15 dBm		5.9		
			-18 dBm		5.8		
			+8 dBm		15.1		
			+4 dBm		10.9		mA
		TX High Power mode	+2 dBm		9		
			-2 dBm		8.3		
			-5 dBm		7.7		

Table	10:	Flectrical	characteristics



BlueNRG

Symbol	Parameter	Test con	ditions	Min.	Тур.	Max.	Uni
•			-8 dBm		7.1		
			-11 dBm		6.8		
			-14 dBm		6.6		
Power co	Disumption when DC-	DC converter not ac	tive				
	-	Reset			5		nA
			RAM2 OFF		1.4		
		Standby	RAM2 ON		2		μA
			32 kHz XO ON (RAM2 OFF)		1.7		
		Class	32kHz XO ON (RAM2 ON)		2.4		
		Sleep	32 kHz RO ON (RAM2 OFF)		2.8		μA
			32 kHz RO ON (RAM2 ON)		3.5		
		Active CPU, Flash and RAM off			2.3		mA
		RX	High Power mode		14.5		m/
		Standard mode		14.3			
I _{BAT}	Supply current		+5 dBm		21		
D/M			0 dBm		15.4		- - - mA
			-2 dBm		13.3		
		TX Standard	-6 dBm		12.2		
		mode	-9 dB		11.5		
			-12 dBm		11		
			-15 dBm		10.6		
			-18 dBm		10.4		
			+8 dBm		28.8		
			+4 dBm		20.5		1
			+2 dBm		17.2		
		TX High Power	-2 dBm		15.3		
	mode	-5 dBm		14		m/	
			-8 dBm		13		
			-11 dBm		12.3]
			-14 dBm		12		
Digital I/		Γ	1	1			1
CIN	Port I/O capacitance			1.29	1.38	1.67	pF



BlueNRG

Electrical specification

Symbol	Parameter	Test con	ditions	Min.	Тур.	Max.	Unit
T _{RISE}	Rise time	0.1*VDD to 0.9*VDD, CL = 50 pF		5		19	ns
T _{FALL}	Fall time	0.9*VDD to 0.1*VDD, CL = 50 pF		6		22	ns
T(RST)	Hold time for reset			1.5			ms
тс	V _{BAT} range			3.0	3.3	3.6	V
TC1	V _{BAT} range			2.25	2.5	2.75	V
VIL	Input low voltage	V _{BAT} range: TC		-0.3		0.8	v
VIL	VIL Input low voltage	V _{BAT} range: TC1		-0.3		0.7	V
VIH	Input high voltage	V _{BAT} range: TC		2.0		3.6	v
VILL	input nigh voltage	V _{BAT} range: TC1		1.7		3.6	v
VOL	Output low voltage	V _{BAT} range: TC				0.4	v
VOL	Output low voltage	V _{BAT} range: TC1				0.7	v
VOH		V _{BAT} range: TC		2.4			v
VOH	Output high voltage	V _{BAT} range: TC1		1.7			v
	Low level output	V _{BAT} range: TC		3.4	5.6	7.9	
IOL	current @ VOL (max.)	V _{BAT} range: TC1		3.8	6.6	10.1	mA
	High level output	V _{BAT} range: TC		5.5	10.6	17.6	
IOH	current @ VOH (min)	V _{BAT} range: TC1		3.7	7.2	12.0	mA



RF general characteristics 10.2

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25 \degree C$, $V_{BAT} = 3.0 V$. All performance data are referred to a 50 W antenna connector, via reference design, QFN32 package version.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
FREQ	Frequency range		2400		2483.5	MHz
F _{CH}	Channel spacing			2		MHz
RF_{ch}	RF channel center frequency		2402		2480	MHz

Table 11: RF general characteristics

RF transmitter characteristics 10.3

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25$ °C, $V_{BAT} = 3.0$ V. All performance data are referred to a 50 W antenna connector, via reference design, QFN32 package version.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
MOD	Modulation scheme			GFS	ĸ	
BT	Bandwidth-bit period product			0.5		
M _{index}	Modulation index		0.45	0.5	0.55	
DR	Air data rate			1		Mbp s
ST _{acc}	Symbol time accuracy				50	ppm
P	Maximum output power at	High power		+8	+10	dBm
P _{MAX}	antenna connector	Standard mode		+5	+7	dBm
P	NA:	High power		-15		
P _{RFC}	Minimum output power	Standard mode		-18		dB
P _{RFC}	RF power accuracy				±2	dB
P _{BW1M}	6 dB bandwidth for modulated carrier (1 Mbps)	Using resolution bandwidth of 100 kHz	500			kHz
P _{RF1}	1 st adjacent channel transmit power 2 MHz	Using resolution bandwidth of 100 kHz and average detector			-20	dBm
P_{RF2}	2 nd adjacent channel transmit power >3 MHz	Using resolution bandwidth of 100 kHz and average detector			-30	dBm
P _{SPUR}	Spurious emission	Harmonics included. Using resolution bandwidth of 1 MHz and average detector			-41	dBm
CF_{dev}	Center frequency deviation	During the packet and including both initial frequency offset and drift			±150	kHz
Freq _{drift}	Frequency drift	During the packet			±50	kHz

Table 12: RF Transmitter characteristics

Electrical specification

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
IFreq _{drift}	Initial carrier frequency drift				±20	kHz
DriftRatemax	Maximum drift rate				400	Hz/µ s
7		Standard mode @ 2440 MHz		25.9 + j44.4		0
Z _{LOAD}	Optimum differential load	High power mode @ 2440 MHz		25.4 + j20.8		Ω

10.4 RF receiver characteristics

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25$ °C, $V_{BAT} = 3.0$ V. All performance data are referred to a 50 W antenna connector, via reference design, QFN32 package version.

Symbol	Parameter	Test condition	ons	Min.	Тур.	Max.	Unit
RX _{SENS}	Sensitivity	BER <0.1%			-88		dBm
P _{SAT}			Standard mode		8		dBm
	Saturation	BER <0.1%	High power mode	_	11		
Z _{IN}	Input differential	Standard mode @ 2440 MHz			31.4 - j26.6		Ω
	impedance	High power mode @ 2440 MHz			28.8		
					- j18.5		
	RF selectivity	with BLE equal modulation	on on interfer	ing sigr	nal		
C/I _{CO-} channel	Co-channel interference	Wanted signal=- 67dBm, BER ≤ 0.1%			9		dBc
C/I _{1 MHz}	Adjacent (+1 MHz) interference	Wanted signal = - 67dBm, BER ≤ 0.1%			2		dBc
C/I _{2 MHz}	Adjacent (+2 MHz) interference	Wanted signal = -67 dBm, BER ≤ 0.1%			-34		dBc
C/I _{3 MHz}	Adjacent (+3 MHz) interference	Wanted signal=- 67dBm, BER ≤ 0.1%		-	-40		dBc
C/I≥₄ MHz	Adjacent (≥ ±4 MHz) interference	Wanted signal = - 67dBm, BER ≤ 0.1%			-34		dBc
C/I≥ _{6 MHz}	Adjacent (≥ ±6 MHz interference	Wanted signal = - 67dBm BER ≤ 0.1%			-45		dBc
C/I≥25 MHz	Adjacent (≥ ±25 MHz) interference	Wanted signal=-67 dBm, BER ≤ 0.1%			-64		dBc

Table	13: RF	receiver	characteristics
i abio	10.101	10001101	0110100101101100



Electrical specification

BlueNRG

specification BlueNRG							
Symbol	Parameter	Test condition	ons	Min.	Тур.	Max.	Unit
C/I _{Image}	Image frequency Interference -2 MHz	Wanted signal=-67 dBm, BER ≤ 0.1%			-20		dBc
	Adjacent (±1 MHz)		-1 MHz		5		
C/I _{Image±1} MHz	Interference to in- band image frequency	Wanted signal=- 67dBm, BER ≤ 0.1%	-3 MHz		-25		dBc
Out of Ban	d blocking (interfering si	gnal CW)	I				
C/I _{Block}	Interfering signal frequency 30 MHz – 2000 MHz	Wanted signal=- 67dBm, BER ≤ 0.1%, Measurement resolution 10 MHz				-30	dBm
C/I _{Block}	Interfering signal frequency	Wanted signal = -67 dBm, BER ≤ 0.1%,		-		-35	dBm
	2003 MHz – 2399 MHz	Measurement resolution 3 MHz					
	Interfering signal frequency	Wanted signal = -67 dBm, BER ≤ 0.1%,					
C/I _{Block}	2484 MHz – 2997 MHz	measurement resolution 3 MHz				-35	dBm
C/I _{Block}	Interfering signal frequency	Wanted signal=- 67dBm, BER ≤ 0.1%,		-		-30	dBm
C/TBIOCK	3000 MHz – 12.75 GHz	measurement resolution 25 MHz				-30	dBill
Intermodul	ation characteristics (CV	V signal at f ₁ , BLE interfe	ering signal at	: f ₂)			
P_IM(3)	Input power of IM interferes at 3 and 6 MHz distance from wanted signal	Wanted signal = -64 dBm, BER ≤ 0.1%			-33		dBm
P_IM(-3)	Input power of IM interferes at -3 and - 6 MHz distance from wanted signal	Wanted signal = -64 dBm, BER ≤ 0.1%			-43		dBm
P_IM(4)	Input power of IM interferes at ±4 and ±8 MHz distance from wanted signal	Wanted signal=- 64dBm, BER ≤ 0.1%			-33		dBm
P_IM(5)	Input power of IM interferes at ±5 and ±10 MHz distance from wanted signal	Wanted signal = -64 dBm, BER ≤ 0.1%			-33		dBm



10.5 High speed crystal oscillator (HSXOSC) characteristics

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25$ °C, $V_{BAT} = 3.0$ V.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
f _{NOM}	Nominal frequency			16/32		MHz
f⊤o∟	Frequency tolerance	Includes initial accuracy, stability over temperature, aging and frequency pulling due to incorrect load capacitance.			±50	ppm
ESR	Equivalent series resistance				100	Ω
PD	Drive level				100	μW

Table 14: High speed crystal oscillator characteristics



10.5.1 High speed crystal oscillator (HSXOSC)

The BlueNRG includes a fully integrated, low power 16/32 MHz Xtal oscillator with an embedded amplitude regulation loop. In order to achieve low power operation and good frequency stability of the Xtal oscillator, certain considerations with respect to the quartz load capacitance C0 need to be taken into account. *Figure 13: "Simplified block diagram of the amplitude regulated oscillator"* shows a simplified block diagram of the amplitude regulated on the BlueNRG.





Low power consumption and fast startup time is achieved by choosing a quartz crystal with a low load capacitance C0. To achieve good frequency stability, the following equation needs to be satisfied:

Equation 1

$$C_0 = \frac{C'_1 * C'_2}{C'_1 + C'_2}$$



Where C1'=C1+CPCB1+CPAD, C2'= C2+CPCB2+CPAD, where C1 and C2 are external (SMD) components, CPCB1 and CPCB2 are PCB routing parasites and CPAD is the equivalent small-signal pad-capacitance. The value of CPAD is around 0.5 pF for each pad. The routing parasites should be minimized by placing quartz and C1/C2 capacitors close to the chip, not only for an easier matching of the load capacitance C0, but also to ensure robustness against noise injection. Connect each capacitor of the Xtal oscillator to ground by a separate via.

10.6 Low speed crystal oscillator (LSXOSC) characteristics

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25$ °C, $V_{BAT} = 3.0$ V.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
f _{NOM}	Nominal frequency			32.768		kHz
f _{TOL}	Frequency tolerance	Includes initial accuracy, stability over temperature, aging and frequency pulling due to incorrect load capacitance.			±50	ppm
ESR	Equivalent series resistance				90	kΩ
PD	Drive level				0.1	μW

Table 15: I	Low speed	crystal oscilla	ator characteristics
14010 1011		er jotar eoein	

Note: These values are the correct ones for NX3215SA-32.768 kHz-EXS00A-MU00003.

10.7 High speed ring oscillator (HSROSC) characteristics

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25$ °C, $V_{BAT} = 3.0$ V, QFN32 package version.

Table 16: Higl	n speed ring oscillate	or charac	teristics	

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
f _{NOM}	Nominal frequency			12	16	MHz

10.8 Low speed ring oscillator (LSROSC) characteristics

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25$ °C, $V_{BAT} = 3.0$ V, QFN32 package version.

Table 17: Low speed ring oscillator characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
32 kHz ring	oscillator (LSROSC)					
f _{NOM}	Nominal frequency			37.4		kHz
f _{TOL}	Frequency tolerance				±500	ppm



10.9 N-fractional frequency synthesizer characteristics

Characteristics measured over recommended operating conditions unless otherwise specified. Typical value are referred to $T_A = 25$ °C, $V_{BAT} = 3.0$ V, $f_c = 2440$ MHz.

Table 18: N-fraction	nal frequency synthesiz	er ch	naracteristi	cs

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	RF carrier phase noise	At ±1MHz offset from carrier		-113		dBc/Hz
		At ±3MHz offset from carrier		-119		dBc/Hz
PN _{SYNTH}		At ±6MHz offset from carrier		TBD		dBc/Hz
		At ±25MHz offset from carrier		TBD		dBc/Hz
LOCKTIME	PLL lock time				40	μs
TOTIME	PLL turn on / hop time	Including calibration			150	μs



11 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.







DocID025108 Rev 6

57

BlueNRG

Package information

Table 19: QFN32 (5 x 5 x 1 pitch 0.5 mm) mechanical data						
Dim	mm					
Dim.	Min.	Тур.	Max.			
А	0.80	0.85	1.00			
A1	0	0.02	0.05			
A3		0.20 REF				
b	0.25	0.25	0.30			
D		5.00 BSC				
E		5.00 BSC				
D2	3.2		3.70			
E2	3.2		3.70			
е		0.5 BSC				
L	0.30	0.40	0.50			
Φ	0°		14°			
К	0.20					

Figure 15: QFN32 (5 x 5 x 1 pitch 0.5 mm) package detail "A"





11.2 WLCSP34 package information

Figure 16: WLCSP34 (2.66 x 2.56 x 0.5 pitch 0.4 mm) package outline



1. The corner of terminal A1 must be identified on the top surface by using a laser marking dot.



BlueNRG

Package information

			P	ackage information				
Table 20: WLCSP34 (2.66 x 2.56 x 0.5 pitch 0.4 mm) mechanical data								
Dim		mm.		Natao				
Dim.	Min.	Тур.	Max.					
А			0.50					
A1		0.20						
b		0.27		(1)				
D	2.50	2.56	2.58	(2)				
D1		2.00						
E	2.60	2.66	2.68	(3)				
E1		2.00						

0.40

0.28 0.33

0.05

Notes:

 $^{(1)}\mbox{The typical ball diameter before mounting is 0.25 mm.}$

 $^{(2)}D = f + D1 + f.$

e f

g

ccc

 $^{(3)}E = g + E1 + g.$



12 PCB assembly guidelines

For Flip Chip mounting on the PCB, STMicroelectronics recommends the use of a solder stencil aperture of 330 x 330 µmmaximum and a typical stencil thickness of 125 µm. Flip Chips are fully compatible with the use of near eutectic 95.8% Sn, 3.5% Ag, 0.7% Cu solder paste with no-clean flux. ST's recommendations for Flip Chip board mounting are illustrated on the soldering reflow profile shown in *Figure 17: "Flip Chip CSP (2.66 x 2.56 x 0.5 pitch 0.4 mm) package reflow profile recommendation"*





 Table 21: Flip Chip CSP (2.66 x 2.56 x 0.5 pitch 0.4 mm) package reflow profile recommendation

Drafila	Value	
Profile	Тур.	Max.
Temp. gradient in preheat (T = 70 – 180 °C)	0.9 °C/s	3 °C/s
Temp. gradient (T = 200 – 225 °C)	2 °C/s	3 °C/s
Peak temp. in reflow	240 - 245 °C	260 °C
Time above 220 °C	60 s	90 s
Temp. gradient in cooling	-2 to - 3 °C/s	-6 °C/s
Time from 50 to 220 °C	160 to 220 s	

Dwell time in the soldering zone (with temperature higher than 220 °C) has to be kept as short as possible to prevent component and substrate damage. Peak temperature must not exceed 260 °C. Controlled atmosphere (N_2 or N_2H_2) is recommended during the whole reflow, especially above 150 °C.

Flip Chips are able to withstand three times the previous recommended reflow profile to be compatible with a double reflow when SMDs are mounted on both sides of the PCB plus one additional repair.

A maximum of three soldering reflows are allowed for these lead-free packages (with repair step included).

The use of a no-clean paste is highly recommended to avoid any cleaning operation. To prevent any bump cracks, ultrasonic cleaning methods are not recommended.



13 Revision history

Table 22: Document revision history

Date	Revision	Changes
09-Aug-2013	1	Initial release.
07-Feb-2014	2	 Datasheet promoted from preliminary data to production data Added WLCSP34 package to <i>Table 1: "Device summary"</i> Deleted references to "low power ADC" throughout the document. Added pin information for the WLCSP package to <i>Figure 3: "BlueNRG pinout top view (WLCSP34)"</i>, <i>Table 2: "Pinout description"</i> Updated <i>Figure 5: "BlueNRG application circuit: active DC-DC converter QFN32 package"</i> and <i>Figure 6: "BlueNRG application circuit: active DC-DC converter WLCSP package"</i> Added <i>Figure 7: "BlueNRG application circuit: active DC-DC converter WLCSP package"</i> Added <i>Figure 7: "BlueNRG application circuit: active DC-DC converter WLCSP package"</i> Added <i>Figure 7: "BlueNRG application circuit: active DC-DC converter WLCSP package"</i> Modified High Performance and Standard Mode values in <i>Table 3: "External component list"</i> Changed all references the term "Slave" to "RAM2 OFF", and "Master" to "RAM2 ON" in Modified <i>Figure 9: "BlueNRG block diagram"</i> Corrected error in typical BSC value for reference "e" in . Added WLCSP package drawing and dimensions data (and) Minor text corrections throughout the document.
19-Mar-2014	3	 Added: Figure 3: "BlueNRG pinout top view (WLCSP34)". Updated: Figure 5: "BlueNRG application circuit: active DC-DC converter QFN32 package" and Figure 6: "BlueNRG application circuit: non active DC-DC converter QFN32 package", Figure 7: "BlueNRG application circuit: active DC-DC converter WLCSP package" and Figure 8: "BlueNRG application circuit: non active DC-DC converter WLCSP package".
21-Mar-2014	4	Added:Section 12: "PCB assembly guidelines".



BlueNRG

Revision history

Date	Revision	Changes	
20-Nov-2014	5	Updated:Bluetooth specification v4.1 compliancy, <i>Table 2:</i> "Pinout description", <i>Table 3:</i> "External component list", <i>Table 8:</i> "Thermal data", <i>Table 14:</i> "High speed crystal oscillator characteristics", <i>Table 15:</i> "Low speed crystal oscillator characteristics", <i>Table 18:</i> "N-fractional frequency synthesizer characteristics", Section 10.7: "High speed ring oscillator (HSROSC) characteristics" and Section 5: "Block diagram and descriptions", Added: Section 10.5.1: "High speed crystal oscillator	
		(HSXOSC)"	
13-May-2015	6	Updated: <i>Features</i> section in cover page; <i>Table 2</i> , replaced reference to Bluetooth specification v4.1 with v4.0 throughout the document, <i>Figure 1: "BlueNRG application block diagram"</i> . Minor changes throughout the document to improve readability.	



IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2015 STMicroelectronics - All rights reserved





Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный) **Факс:** 8 (812) 320-02-42 **Электронная почта:** <u>org@eplast1.ru</u> **Адрес:** 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.